

Certificate of Analysis

ULTRAgrade[™] Solution Iron ICP / ICP-MS Standard 10000 µg/mL

Catalog Number: ICP-126 Lot Number: CL-5275 Lot Issue Date: 12/19/2014 Expiration Date: 01/31/2022

Starting Material: iron (III) nitrate
Starting Material Purity: 99.9999%
Starting Material Lot #: RM07199

Matrix: 2% nitric acid in low TOC water (< 50 ppb)

Atomic Weight Fe: 55.85

Certified Value: 10006 ± 20 µg/mL

This Certified Reference Material (CRM) was manufactured and verified in accordance with ULTRA's ISO 9001 registered quality system. The analyte concentration(s) were prepared and verified by an ISO Guide 34 / ISO 17025 accredited laboratory, and compared to calibration standards independently prepared using NIST SRM(s). The certified value and uncertainty value at the 95% confidence level for each analyte is determined gravimetrically.

Classical Wet Assay Method: Theoretical, based on gravimetric measurements

Confirmation by Inductively Coupled Plasma Spectroscopy (ICP / ICP/MS) vs. NIST SRM 3126a

ULTRA uses purified acids, 18 megohm double deionized water, calibrated Class A glassware & meticulously cleaned bottles in the

manufacturing of ULTRAgrade standards. Balances used in the manufacturing of this standard are calibrated with weights traceable to NIST in compliance with ANSI/NCSL Z-540-1 and ISO 9001.

Trace Metallic Impurities in Solution Standard in µg/mL:

*	ΑI	< 0.005	ND	*	Ga	< 0.005	ND	<u>!</u>	<u>N</u> b			<u>n</u>	_ s		
*	Sb	<0.005	ND	<u>n</u>	Ge			<u> </u>	<u> </u>			<u>n</u>	Ta		
*	As	< 0.005	ND	<u>n</u>	Au			1	Pd	< 0.005	ND	<u>n</u>	Te		
*	Ba	< 0.005	ND	n	Hf			•	P	< 0.005	ND	n	Tb		
*	Be	< 0.005	ND	n	Ho			,	Pt	< 0.005	ND	*	TI	< 0.005	ND
*	Bi	< 0.005	ND	*	In	< 0.005	ND	1	K	< 0.005	ND	<u>n</u>	Th		
*	В	< 0.005	ND	<u>n</u>	lr			1	<u>n</u> Pr			<u>n</u>	Tm		
*	Cd	< 0.005	ND	S	Fe			1	n_ Re			*	Sn	< 0.005	ND
*	Ca	< 0.005	D	*	La	< 0.005	ND	Ī	n Rh			*	Ti	< 0.005	ND
n	Ce			*	Pb	< 0.005	ND	<u> </u>	n Rb			n	W		
n	Cs			*	Li	< 0.005	ND	Ī	n Ru			n	U		
*	Cr	< 0.005	ND	*	Lu			<u> </u>	Sm			*		< 0.005	ND
*	Co	< 0.005	ND	*	Mg	< 0.005	ND	Ī	n Sc			n	Yb		
*	Cu	< 0.005	ND	*	Mn	< 0.005	ND	7	Se	< 0.005	ND	n	Y		
n	Dy			*	Hg	< 0.005	ND	-	Si	< 0.005	ND	*	_ Zn	< 0.005	ND
*	Εŕ	< 0.005	ND	*	Mo	< 0.005	ND	,	Ag	< 0.005	ND	n	 Zr		
*	Eu	< 0.005	ND	n	Nd			,	Na	< 0.005	ND				
*	Gd	< 0.005	ND	*	Ni	< 0.005	ND	,	Sr	< 0.005	ND				
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 * - element checked for I – spectral interference n – not checked for

ND – not detected D – detected s – solution standard element

Density of Solution (measured at 19.99°C ± 0.05°C): 1.0459 g/mL

ACCREDITED

ISO 17025:2005 Accredited A2LA Cert. No. 0851.01 ISO 9001:2000 Registered TUV USA, Inc. Cert. No. 06-1004 William J. Lear Quality Assurance Manager